


<b>Search Notes</b> 	<b>Application/Control No.</b> 10566993	<b>Applicant(s)/Patent Under Reexamination</b> AREDDU ET AL.
	<b>Examiner</b> FAN NG	<b>Art Unit</b> 2471

SEARCHED			
Class	Subclass	Date	Examiner
370	351,357,229,230,230.1 (text search only)	11/04/08	FN
379	111,112.01,112.06,112.1 (text search only)	11/04/08	FN
	Update all previous search	06/03/2009	FN
	Update all previous search	01/06/2010	FN
	Update all previous search	08/09/2010	FN

SEARCH NOTES		
Search Notes	Date	Examiner
East	11/04/08	FN
Inventor name search in PALM	11/04/08	FN
Double patent search	11/04/08	FN
IEEE, NPL search	08/09/2010	FN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	See interference search result	08/09/2010	FN

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